

Materials/chemicals/pharmaceuticals/battery materials

Evaluation of material characteristics and properties, R&D, experimentation

Measuring volume resistivity and surface resistivity of conductive materials using the four-point probe method

The four-point probe method can be used to measure volume resistivity, surface resistivity, and conductivity.

The four-point probe method is the four-terminal measurement using four-point array probes and with RCF calculation.

It can be used to calculate volume resistivity and surface resistivity (sheet resistance). Four-point probe resistivity measurement is made possible by the Resistance Meter RM3545, four-point array probes, and PC application software.

Highlights

• Hioki provides four-point array probes in two variants with probe spacing of 5.0 mm and 1.5 mm.

• Hioki provides two types of PC application software: for cuboid DUTs and for solid cylindrical DUTs.

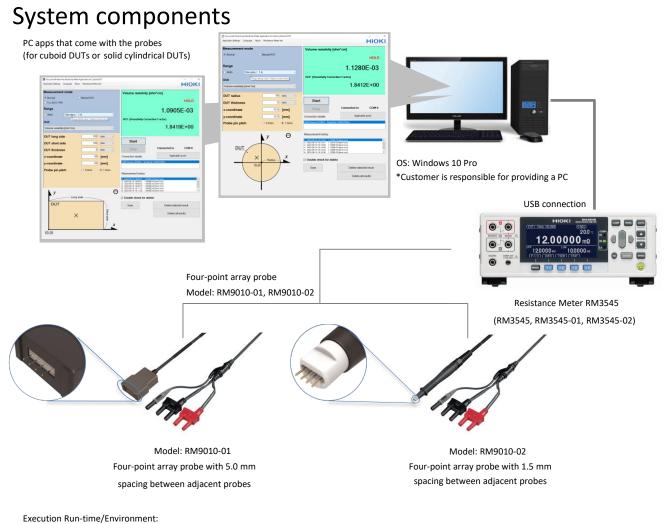
• Measured parameters include volume resistivity, surface resistivity, and conductivity. Resistance values can also be chosen as a reference value.

• The application displays RCF (Resistivity Correction Factor) calculated based on the entered DUT dimensions and measurement position coordinates.

• The application provides convenient functionality of a probing position guide, a measurement history, and outputting measurement results as a CSV file.

• Low resistance values are measured with basic accuracy of 0.006% and a maximum resolution of 0.01 $\mu\Omega$ (as per the RM3545's specifications), allowing volume resistivity to be calculated with a high degree of precision.





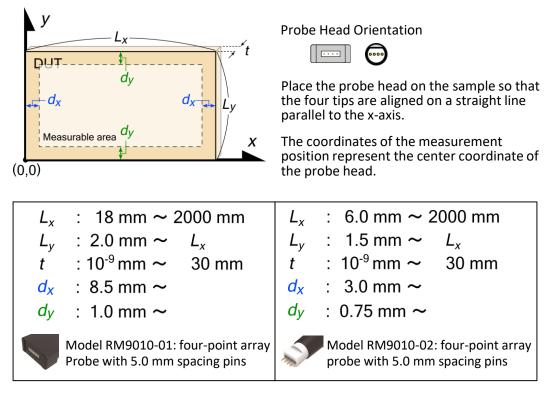
.NET Framework 4.6.1 or one of the versions compatible with .NET Framework 4.6.1 Note: Download and install .NET Framework from Microsoft's support website.

Four-point Probe Array Resistivity Meter Application

Recommended operating environment :

Supported Operating system	Windows 10 Pro (32 bits/64 bits)	
CPU	Intel(R) Core(TM) i7, 2.4 GHz, 4 threads or better	
	(recommended)	
Memory	8 GB or more recommended	
	(4 GB or more available RAM recommended)	
Display	1050 × 1050 pixels or more recommended,	
	32768 colors or more recommended	
Hard disk	Free capacity 2 GB or more recommended	
Communication interface	USB 2.0 (virtual COM port)	
Application run-time execution	.NET Framework 4.6.1 or one of the versions compatible	
environment	with .NET Framework 4.6.1	
	Note: Download and install .NET Framework from Microsoft's	
	support website.	

Measurement conditions for cuboid DUT application (measurement mode: Normal)



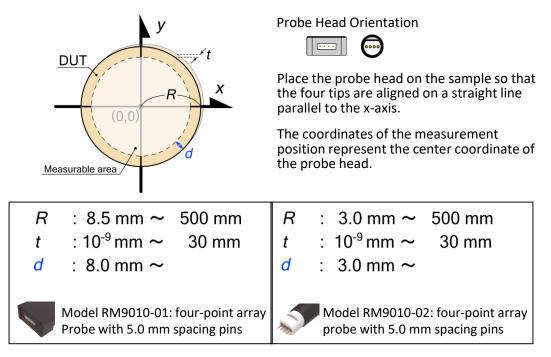
Set the DUT dimensions and probe conditions. The setting value has 5 significant digits and up to 2 decimal places.

1. DUT length Enter the DUT length of the longs side. Settable range RM9010-01: 18 mm to 2000 mm RM9010-02: 6.0 mm to 2000 mm



2. DUT width Enter the DUT width of the short side. Settable range RM9010-01: 2.0 mm to the length above RM9010-02: 1.5 mm to the length above 3. DUT thickness Enter the DUT thickness. Settable range RM9010-01: 10⁻⁹ mm to 30 mm RM9010-02: 10⁻⁹ mm to 30 mm 4. x-coordinate Enter the x-coordinate of the probing position. Enter the center coordinate of the probing head. Settable range RM9010-01: Enter a coordinate within the DUT and 8.5 mm or more inward from its short side. RM9010-02: Enter a coordinate within the DUT and 3.0 mm or more inward from its short side. 5. y-coordinate Enter the y-coordinate of the probing position. Enter the center coordinate of the probing head. Settable range RM9010-01: Enter a coordinate within the DUT and 1.0 mm or more inward from its long side. RM9010-02: Enter a coordinate within the DUT and 0.75 mm or more inward from its long side.

Measurement conditions for solid cylindrical DUT application (measurement mode: Normal)



Set the DUT dimensions and probe conditions. The setting value has 5 significant digits and up to 2 decimal places.

1. DUT radius Enter the DUT radius. Settable range RM9010-01: 8.5 mm to 500 mm RM9010-02: 3.0 mm to 500 mm



2. DUT thickness
Enter the DUT thickness.
Settable range
RM9010-01: 10⁻⁹ mm to 30 mm
RM9010-02: 10⁻⁹ mm to 30 mm
3. (x, y) coordinates
Enter the (x, y) coordinates of the probing position. Enter the center coordinate of the probing head.
Settable range
RM9010-01: Enter (x, y) coordinates which exist 8.0 mm or more inward from the edge of the DUT.
RM9010-02: Enter (x, y) coordinates which exist 3.0 mm or more inward from the edge of the DUT.

Settable resistance range and applied current with the application software

10 MΩ/1 uA	1000 kΩ/10 uA	100 kΩ/100 uA	10 kΩ/1 mA	1000 Ω/1 mA
100 Ω/1 mA	10 Ω/1 mA	1000 mΩ/10 mA	100 mΩ/100 mA	10 mΩ/1 A

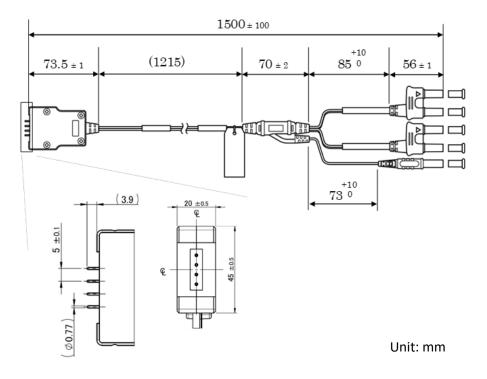
Four-point array probe model RM9010-01, RM9010-02

Model RM9010-01: specifications

Probe material	Base material: Beryllium copper
	Plating: Gold (primary nickel plating)
Probe diameter	Approx. 0.77 mm
Probe tip shape	Spherical
Probe array	Collinear
Spacing between adjacent probes	5.0 mm ±0.1 mm
	(with every probe thrust against an object)
Insulation resistance between adjacent probes	10 G Ω or more for an applied voltage of 25 V at an
	ambient temperature of 23°C and relative humidity of
	35% RH (reference value)
Probe spring force	1.25 N ±0.25 N
(per spring)	(with every probe thrust against an object)
Maximum rated terminal-to-ground	30 V AC rms or less, 42.4 V AC peak or less, 60 V
voltage	DC or less
Rated current	3 A AC/DC continuous
Operating temperature and	0°C to 40°C (32°F to 104°F), 80% RH or less
humidity range	(non-condensing)
Storage temperature and	-10°C to 50°C (14°F to 122°F), 80% RH or less
humidity range	(non-condensing)
Operating environment	Indoors, pollution degree 2,
	operating altitude: up to 2000 m (6562 ft.)
Dimensions	About 1500 mm (59.06")
Weight	About 200 g (7.1 oz.)



Model RM9010-01: outline drawing

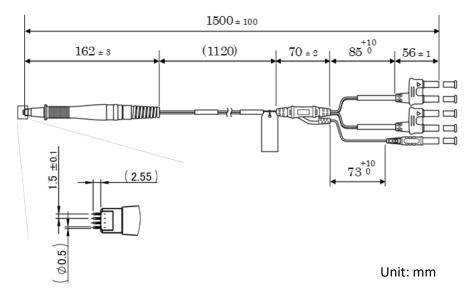


Model RM9010-02: specifications

Probe material	Base material: Beryllium copper		
	Plating: Gold (primary nickel plating)		
Probe diameter	Approx. 0.5 mm		
Probe tip shape	Spherical		
Probe array	Collinear		
Spacing between adjacent probes	1.5 mm ±0.1 mm		
	(with every probe thrust against an object)		
Insulation resistance between	10 G Ω or more for an applied voltage of 25 V at an		
	ambient temperature of 23°C and relative humidity of		
adjacent probes	35% RH (reference value)		
Probe spring force	About 0.85 N		
(per spring)	(with every probe thrust against an object)		
Maximum rated terminal-to-ground	30 V AC rms or less, 42.4 V AC peak or less, 60 V		
voltage	DC or less		
Rated current	1.5 A AC/DC continuous		
Operating temperature and	0°C to 40°C (32°F to 104°F), 80% RH or less		
humidity range	(non-condensing)		
Storage temperature and	-10°C to 50°C (14°F to 122°F), 80% RH or less		
humidity range	(non-condensing)		
Operating environment	Indoors, pollution degree 2,		
	operating altitude: up to 2000 m (6562 ft.)		
Dimensions	About 1500 mm (59.06")		
Weight	About 150 g (5.3 oz.)		



Model RM9010-02: outline drawing



Please contact Hioki via the following web site:

HIOKI E. E. CORPORATION https://www.hioki.com/global

Information valid as of June 2022.

The contents in this application note are subject to change and revision without notice.

Microsoft, Windows and .NET Framework are either registered trademarks or trademarks of Microsoft Corporation in the United States and other countries.

Intel is a trademark or registered trademark of Intel Corporation or its subsidiaries in the United States and other countries. Other products and company names are trade names, registered trademarks, or trademarks of their respective owners.